



<p style="text-align: center;"><b>Searched</b></p> 	<p>Application/Control No.</p> <p>10658889</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>SUZU, HIROKAZU</p>
	<p>Examiner</p> <p>SINARS, JAMES R</p>	<p>Art Unit</p> <p>2635</p>

Class	SubClass	Date	Examiner
725	46	10/18/06	J. Sinars
725	50	10/18/06	J. Sinars
725	37	10/18/06	J. Sinars
725	38	10/18/06	J. Sinars
725	40	10/18/06	J. Sinars
725	42	10/18/06	J. Sinars
725	100	10/18/06	J. Sinars
725	131	10/18/06	J. Sinars
725	120	10/18/06	J. Sinars
725	118	10/18/06	J. Sinars
725	45	10/18/06	J. Sinars
348	838	10/18/06	J. Sinars
348	465	10/18/06	J. Sinars
348	725	10/18/06	J. Sinars
725	58	10/19/06	J. Sinars

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<b>Search Notes</b>  	Application/Control No.  10658889	Applicant(s)/Patent Under Reexamination  SUZU, HIROKAZU
	Examiner  SINARS, JAMES R	Art Unit  2635

Notes	Date	Examiner
Consulted w/Vu Le re: duplicate claim analysis	10/12/2006	J. Sinars
Consulted w/Lin Ye re: using foreign priority date as prior art date	10/12/2006	J. Sinars
Consulted w/QEM meeting re: search references	10/18/2006	J. Sinars
Consulted w/ Justin Shepard re: search references	10/18/2006	J. Sinars
Consulted w/Vu Le re: OSD vs PIP relationship	10/24/06	J. Sinars
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